

KA78MXX

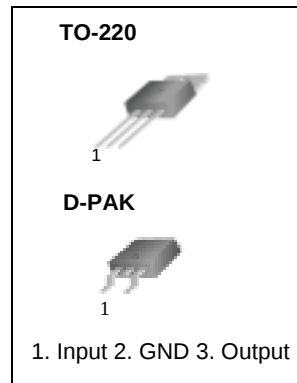
3-Terminal 0.5A Positive Voltage Regulator

Features

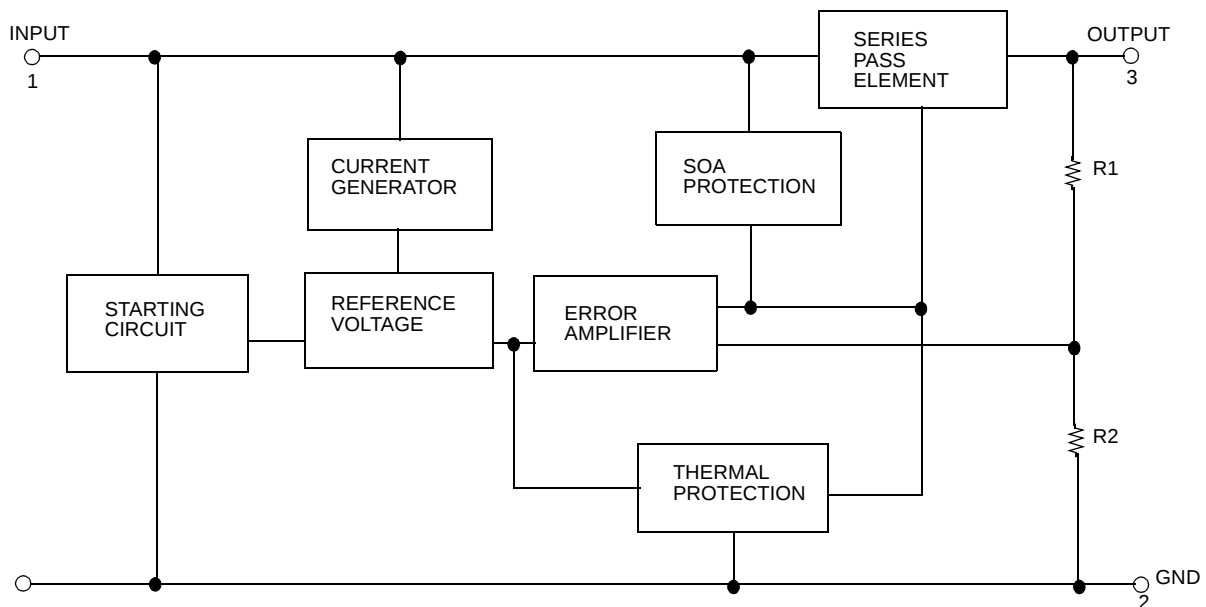
- Output Current up to 0.5A
- Output Voltages of 5, 6, 8, 12, 15, 18, 24V
- Thermal Overload Protection
- Short Circuit Protection
- Output Transistor Safe Operating Area (SOA) Protection

Description

The KA78MXX series of three terminal positive regulators are available in the TO-220/D-PAK package with several fixed output voltages making it useful in a wide range of applications.



Internal Block Diagram



Absolute Maximum Ratings

Parameter	Symbol	Value	Unit
Input Voltage (for $V_O = 5V$ to $18V$) (for $V_O = 24V$)	V_I	35	V
	V_I	40	V
Thermal Resistance Junction-Cases (Note1) TO-220	$R_{\theta JC}$	2.5	$^{\circ}C/W$
Thermal Resistance Junction-Air (Note1,2) TO-220 D-PAK	$R_{\theta JA}$	66	$^{\circ}C/W$
		92	
Operating Temperature Range	T_{OPR}	$0 \sim +125$	$^{\circ}C$
Storage Temperature Range	T_{STG}	$-65 \sim +150$	$^{\circ}C$

Electrical Characteristics (KA78M05/KA78M05R)

(Refer to the test circuits, $0 \leq T_J \leq +125^{\circ}C$, $I_O = 350mA$, $V_I = 10V$, unless otherwise specified, $C_I = 0.33\mu F$, $C_O = 0.1\mu F$)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Output Voltage	V_O	$T_J = +25^{\circ}C$	4.8	5	5.2	V
		$I_O = 5$ to $350mA$ $V_I = 7$ to $20V$	4.75	5	5.25	
Line Regulation (Note3)	ΔV_O	$I_O = 200mA$ $T_J = +25^{\circ}C$	-	-	100	me
		$V_I = 7$ to $25V$ $V_I = 8$ to $25V$	-	-	50	
Load Regulation (Note3)	ΔV_O	$I_O = 5mA$ to $0.5A$, $T_J = +25^{\circ}C$	-	-	100	mV
		$I_O = 5mA$ to $200mA$, $T_J = +25^{\circ}C$	-	-	50	
Quiescent Current	I_Q	$T_J = +25^{\circ}C$	-	4.0	6.0	mA
Quiescent Current Change	ΔI_Q	$I_O = 5mA$ to $350mA$	-	-	0.5	mA
		$I_O = 200mA$ $V_I = 8$ to $25V$	-	-	0.8	
Output Voltage Drift	$\Delta V/\Delta T$	$I_O = 5mA$ $T_J = 0$ to $+125^{\circ}C$	-	-0.5	-	mV/ $^{\circ}C$
Output Noise Voltage	V_N	$f = 10Hz$ to $100kHz$	-	40	-	$\mu V/V_O$
Ripple Rejection	RR	$f = 120Hz$, $I_O = 300mA$ $V_I = 8$ to $18V$	62	-	-	dB
Dropout Voltage	V_D	$T_J = +25^{\circ}C$, $I_O = 500mA$	-	2	-	V
Short Circuit Current	ISC	$T_J = +25^{\circ}C$, $V_I = 35V$	-	300	-	mA
Peak Current	I_{PK}	$T_J = +25^{\circ}C$	-	700	-	mA

Note:

- Thermal resistance test board
Size: 76.2mm * 114.3mm * 1.6mm(1S0P)
JEDEC standard: JESD51-3, JESD51-7
- Assume no ambient airflow
- Load and line regulation are specified at constant junction temperature. Change in V_O due to heating effects must be taken into account separately. Pulse testing with low duty is used.

Electrical Characteristics (KA78M06/KA78M06R) (Continued)

(Refer to the test circuits, $0 \leq T_J \leq +125^\circ\text{C}$, $I_O = 350\text{mA}$, $V_I = 11\text{V}$, unless otherwise specified, $C_I = 0.33\mu\text{F}$, $C_O = 0.1\mu\text{F}$)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Output Voltage	V_O	$T_J = +25^\circ\text{C}$	5.75	6	6.25	V
		$I_O = 5 \text{ to } 350\text{mA}$ $V_I = 8 \text{ to } 21\text{V}$	5.7	6	6.3	
Line Regulation (Note1)	ΔV_O	$I_O = 200\text{mA}$ $T_J = +25^\circ\text{C}$ $V_I = 8 \text{ to } 25\text{V}$	-	-	100	mV
		$V_I = 9 \text{ to } 25\text{V}$	-	-	50	
Load Regulation (Note1)	ΔV_O	$I_O = 5\text{mA} \text{ to } 0.5\text{A}$, $T_J = +25^\circ\text{C}$	-	-	120	mV
		$I_O = 5\text{mA} \text{ to } 200\text{mA}$, $T_J = +25^\circ\text{C}$	-	-	60	
Quiescent Current	I_Q	$T_J = +25^\circ\text{C}$	-	4.0	6.0	mA
Quiescent Current Change	ΔI_Q	$I_O = 5\text{mA} \text{ to } 350\text{mA}$	-	-	0.5	mA
		$I_O = 200\text{mA}$ $V_I = 9 \text{ to } 25\text{V}$	-	-	0.8	
Output Voltage Drift	$\Delta V/\Delta T$	$I_O = 5\text{mA}$ $T_J = 0 \text{ to } +125^\circ\text{C}$	-	-0.5	-	mV/ $^\circ\text{C}$
Output Noise Voltage	V_N	$f = 10\text{Hz} \text{ to } 100\text{kHz}$	-	45	-	$\mu\text{V}/V_O$
Ripple Rejection	RR	$f = 120\text{Hz}$, $I_O = 300\text{mA}$ $V_I = 11.5 \text{ to } 21.5\text{V}$	59	-	-	dB
Dropout Voltage	V_D	$T_J = +25^\circ\text{C}$, $I_O = 500\text{mA}$	-	2	-	V
Short Circuit Current	I_{SC}	$T_J = +25^\circ\text{C}$, $V_I = 35\text{V}$	-	300	-	mA
Peak Current	I_{PK}	$T_J = +25^\circ\text{C}$	-	700	-	mA

Note:

1. Load and line regulation are specified at constant, junction temperature. Change in V_O due to heating effects must be taken into account separately. Pulse testing with low duty is used.

Electrical Characteristics (KA78M08/KA78M08R) (Continued)(Refer to the test circuits, $0 \leq T_J \leq +125^\circ\text{C}$, $I_O = 350\text{mA}$, $V_I = 14\text{V}$, unless otherwise specified, $C_I = 0.33\mu\text{F}$, $C_O = 0.1\mu\text{F}$)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Output Voltage	V_O	$T_J = +25^\circ\text{C}$	7.7	8	8.3	V
		$I_O = 5 \text{ to } 350\text{mA}$ $V_I = 10.5 \text{ to } 23\text{V}$	7.6	8	8.4	
Line Regulation (Note1)	ΔV_O	$I_O = 200\text{mA}$ $T_J = +25^\circ\text{C}$	-	-	100	mV
		$V_I = 11 \text{ to } 25\text{V}$	-	-	50	
Load Regulation (Note1)	ΔV_O	$I_O = 5\text{mA} \text{ to } 0.5\text{A}$, $T_J = +25^\circ\text{C}$	-	-	160	mV
		$I_O = 5\text{mA} \text{ to } 200\text{mA}$, $T_J = +25^\circ\text{C}$	-	-	80	
Quiescent Current	I_Q	$T_J = +25^\circ\text{C}$	-	4.0	6.0	mA
Quiescent Current Change	ΔI_Q	$I_O = 5\text{mA} \text{ to } 350\text{mA}$	-	-	0.5	mA
		$I_O = 200\text{mA}$ $V_I = 10.5 \text{ to } 25\text{V}$	-	-	0.8	
Output Voltage Drift	RR	$I_O = 5\text{mA}$ $T_J = 0 \text{ to } +125^\circ\text{C}$	-	-0.5	-	mV/ $^\circ\text{C}$
Output Noise Voltage	V_N	$f = 10\text{Hz} \text{ to } 100\text{kHz}$	-	52	-	$\mu\text{V}/V_O$
Ripple Rejection	RR	$f = 120\text{Hz}$, $I_O = 300\text{mA}$ $V_I = 9 \text{ to } 19\text{V}$	56	-	-	dB
Dropout Voltage	V_D	$T_J = +25^\circ\text{C}$, $I_O = 500\text{mA}$	-	2	-	V
Short Circuit Current	ISC	$T_J = +25^\circ\text{C}$, $V_I = 35\text{V}$	-	300	-	mA
Peak Current	I_{PK}	$T_J = +25^\circ\text{C}$	-	700	-	mA

Note:

1. Load and line regulation are specified at constant, junction temperature. Change in V_O due to heating effects must be taken into account separately. Pulse testing with low duty is used.

Electrical Characteristics (KA78M12/KA78M12R) (Continued)

(Refer to the test circuits, $0 \leq T_J \leq +125^\circ\text{C}$, $I_O = 350\text{mA}$, $V_I = 19\text{V}$, unless otherwise specified, $C_I = 0.33\mu\text{F}$, $C_O = 0.1\mu\text{F}$)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Output Voltage	V_O	$T_J = +25^\circ\text{C}$	11.5	12	12.5	V
		$I_O = 5 \text{ to } 350\text{mA}$ $V_I = 14.5 \text{ to } 27\text{V}$	11.5	12	12.6	
Line Regulation (Note1)	ΔV_O	$I_O = 200\text{mA}$ $T_J = +25^\circ\text{C}$	-	-	100	mV
		$V_I = 14.5 \text{ to } 30\text{V}$ $V_I = 16 \text{ to } 30\text{V}$	-	-	50	
Load Regulation (Note1)	ΔV_O	$I_O = 5\text{mA} \text{ to } 0.5\text{A}$, $T_J = +25^\circ\text{C}$	-	-	240	mV
		$I_O = 5\text{mA} \text{ to } 200\text{mA}$, $T_J = +25^\circ\text{C}$	-	-	120	
Quiescent Current	I_Q	$T_J = +25^\circ\text{C}$	-	4.1	6.0	mA
Quiescent Current Change	ΔI_Q	$I_O = 5\text{mA} \text{ to } 350\text{mA}$	-	-	0.5	mA
		$I_O = 200\text{mA}$ $V_I = 14.5 \text{ to } 30\text{V}$	-	-	0.8	
Output Voltage Drift	$\Delta V/\Delta T$	$I_O = 5\text{mA}$ $T_J = 0 \text{ to } +125^\circ\text{C}$	-	-0.5	-	mV/ $^\circ\text{C}$
Output Noise Voltage	V_N	$f = 10\text{Hz} \text{ to } 100\text{kHz}$	-	75	-	$\mu\text{V}/V_O$
Ripple Rejection	RR	$f = 120\text{Hz}$, $I_O = 300\text{mA}$ $V_I = 15 \text{ to } 25\text{V}$	55		-	dB
Dropout Voltage	V_D	$T_J = +25^\circ\text{C}$, $I_O = 500\text{mA}$	-	2	-	V
Short Circuit Current	I_{SC}	$T_J = +25^\circ\text{C}$, $V_I = 35\text{V}$	-	300	-	mA
Peak Current	I_{PK}	$T_J = +25^\circ\text{C}$	-	700	-	mA

Note:

1. Load and line regulation are specified at constant, junction temperature. Change in V_O due to heating effects must be taken into account separately. Pulse testing with low duty is used.

Electrical Characteristics (KA78M15) (Continued)

(Refer to the test circuits, $0 \leq T_J \leq +125^\circ\text{C}$, $I_O = 350\text{mA}$, $V_I = 23\text{V}$, unless otherwise specified, $C_I = 0.33\mu\text{F}$, $C_O = 0.1\mu\text{F}$)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Output Voltage	V_O	$T_J = +25^\circ\text{C}$	14.4	15	15.6	V
		$I_O = 5 \text{ to } 350\text{mA}$ $V_I = 17.5 \text{ to } 30\text{V}$	14.25	15	15.75	
Line Regulation (Note1)	ΔV_O	$I_O = 200\text{mA}$ $T_J = +25^\circ\text{C}$	-	-	100	mV
		$V_I = 17.5 \text{ to } 30\text{V}$ $V_I = 20 \text{ to } 30\text{V}$	-	-	50	
Load Regulation (Note1)	ΔV_O	$I_O = 5\text{mA} \text{ to } 0.5\text{A}$, $T_J = +25^\circ\text{C}$	-	-	300	mV
		$I_O = 5\text{mA} \text{ to } 200\text{mA}$, $T_J = +25^\circ\text{C}$	-	-	150	
Quiescent Current	I_Q	$T_J = +25^\circ\text{C}$	-	4.1	6.0	mA
Quiescent Current Change	ΔI_Q	$I_O = 5\text{mA} \text{ to } 350\text{mA}$	-	-	0.5	mA
		$I_O = 200\text{mA}$ $V_I = 17.5 \text{ to } 30\text{V}$	-	-	0.8	
Output Voltage Drift	$\Delta V/\Delta T$	$I_O = 5\text{mA}$ $T_J = 0 \text{ to } +125^\circ\text{C}$	-	-1	-	mV/ $^\circ\text{C}$
Output Noise Voltage	V_N	$f = 10\text{Hz} \text{ to } 100\text{kHz}$	-	100	-	$\mu\text{V}/V_O$
Ripple Rejection	RR	$f = 120\text{Hz}$, $I_O = 300\text{mA}$ $V_I = 18.5 \text{ to } 28.5\text{V}$	54	-	-	dB
Dropout Voltage	V_D	$T_J = +25^\circ\text{C}$, $I_O = 500\text{mA}$	-	2	-	V
Short Circuit Current	I_{SC}	$T_J = +25^\circ\text{C}$, $V_I = 35\text{V}$	-	300	-	mA
Peak Current	I_{PK}	$T_J = +25^\circ\text{C}$	-	700	-	mA

Note:

1. Load and line regulation are specified at constant, junction temperature. Change in V_O due to heating effects must be taken into account separately. Pulse testing with low duty is used.

Electrical Characteristics (KA78M18) (Continued)

(Refer to the test circuits, $0 \leq T_J \leq +125^\circ\text{C}$, $I_O=350\text{mA}$, $V_I=26\text{V}$, unless otherwise specified, $C_I=0.33\mu\text{F}$, $C_O=0.1\mu\text{F}$)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Output Voltage	V_O	$T_J = +25^\circ\text{C}$	17.3	18	18.7	V
		$I_O = 5 \text{ to } 350\text{mA}$ $V_I = 20.5 \text{ to } 33\text{V}$	17.1	18	18.9	
Line Regulation (Note1)	ΔV_O	$I_O = 200\text{mA}$ $T_J = +25^\circ\text{C}$	-	-	100	mV
		$V_I = 21 \text{ to } 33\text{V}$ $V_I = 24 \text{ to } 33\text{V}$			50	
Load Regulation (Note1)	ΔV_O	$I_O = 5\text{mA} \text{ to } 0.5\text{A}$, $T_J = +25^\circ\text{C}$	-	-	360	mV
		$I_O = 5\text{mA} \text{ to } 200\text{mA}$, $T_J = +25^\circ\text{C}$	-	-	180	
Quiescent Current	I_Q	$T_J = +25^\circ\text{C}$	-	4.2	6.0	mA
Quiescent Current Change	ΔI_Q	$I_O = 5\text{mA} \text{ to } 350\text{mA}$	-	-	0.5	mA
		$I_O = 200\text{mA}$ $V_I = 21 \text{ to } 33\text{V}$	-	-	0.8	
Output Voltage Drift	$\Delta V/\Delta T$	$I_O = 5\text{mA}$, $T_J = 0 \text{ to } 125^\circ\text{C}$	-	-1.1	-	mV/ $^\circ\text{C}$
Output Noise Voltage	V_N	$f = 10\text{Hz} \text{ to } 100\text{kHz}$	-	100	-	$\mu\text{V}/V_O$
Ripple Rejection	RR	$f = 120\text{Hz}$, $I_O=300\text{mA}$, $V_I=22 \text{ to } 32\text{V}$	53	-	-	dB
Dropout Voltage	V_D	$T_J = +25^\circ\text{C}$, $I_O=500\text{mA}$	-	2	-	V
Short Circuit Current	I_{SC}	$T_J = +25^\circ\text{C}$, $V_I=35\text{V}$	-	300	-	mA
Peak Current	I_{PK}	$T_J = +25^\circ\text{C}$	-	700	-	mA

Note:

1. Load and line regulation are specified at constant, junction temperature. Change in V_O due to heating effects must be taken into account separately. Pulse testing with low duty is used.

Electrical Characteristics (KA78M24) (Continued)

(Refer to the test circuits, $0 \leq T_J \leq +125^\circ\text{C}$, $I_O = 350\text{mA}$, $V_I = 33\text{V}$, unless otherwise specified, $C_I = 0.33\mu\text{F}$, $C_O = 0.1\mu\text{F}$)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Output Voltage	V_O	$T_J = +25^\circ\text{C}$	23	24	25	V
		$I_O = 5 \text{ to } 350\text{mA}$ $V_I = 27 \text{ to } 38\text{V}$	22.8	24	25.2	
Line Regulation	ΔV_O	$I_O = 200\text{mA}$ $T_J = +25^\circ\text{C}$	-	-	100	mV
		$V_I = 27 \text{ to } 38\text{V}$ $V_I = 28 \text{ to } 38\text{V}$	-	-	50	
Load Regulation	ΔV_O	$I_O = 5\text{mA} \text{ to } 0.5\text{A}$, $T_J = +25^\circ\text{C}$	-	-	480	mV
		$I_O = 5\text{mA} \text{ to } 200\text{mA}$, $T_J = +25^\circ\text{C}$	-	-	240	
Quiescent Current	I_Q	$T_J = +25^\circ\text{C}$	-	4.2	6	mA
Quiescent Current Change	ΔI_Q	$I_O = 5\text{mA} \text{ to } 350\text{mA}$	-	-	0.5	mA
		$I_O = 200\text{mA}$ $V_I = 27 \text{ to } 38\text{V}$	-	-	0.8	
Output Voltage Drift	$\Delta V/\Delta T$	$I_O = 5\text{mA}$ $T_J = 0 \text{ to } +125^\circ\text{C}$	-	-1.2	-	mV/ $^\circ\text{C}$
Output Noise Voltage	V_N	$f = 10\text{Hz} \text{ to } 100\text{kHz}$	-	170	-	μV
Ripple Rejection	RR	$f = 120\text{Hz}$, $I_O = 300\text{mA}$ $V_I = 28 \text{ to } 38\text{V}$	50	-	-	dB
Dropout Voltage	V_D	$T_J = +25^\circ\text{C}$, $I_O = 500\text{mA}$	-	2	-	V
Short Circuit Current	I_{SC}	$T_J = +25^\circ\text{C}$, $V_I = 35\text{V}$	-	300	-	mA
Peak Current	I_{PK}	$T_J = +25^\circ\text{C}$	-	700	-	mA

Note:

1. Load and line regulation are specified at constant, junction temperature. Change in V_O due to heating effects must be taken into account separately. Pulse testing with low duty is used.

Typical Applications

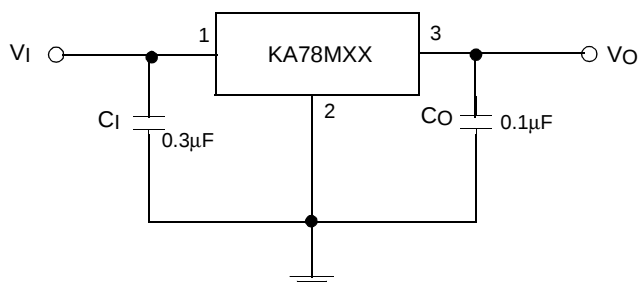


Figure 1. Fixed Output Regulator

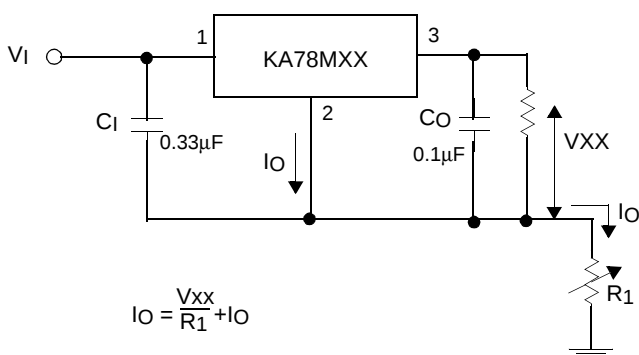


Figure 2. Constant Current Regulator

Notes:

1. To specify an output voltage, substitute voltage value for "XX"
2. Although no output capacitor is needed for stability, it does improve transient response.
3. Required if regulator is located an appreciable distance from power Supply filter

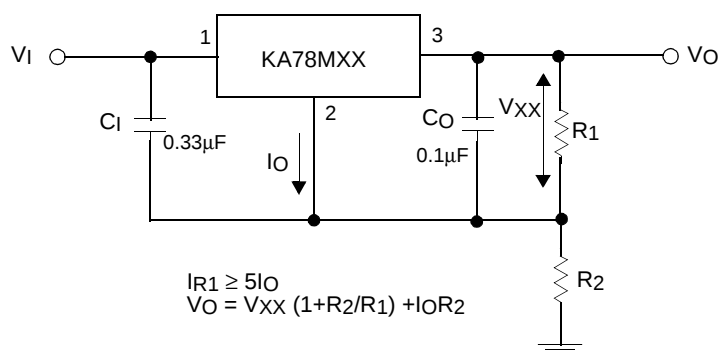


Figure 3. Circuit for Increasing Output Voltage

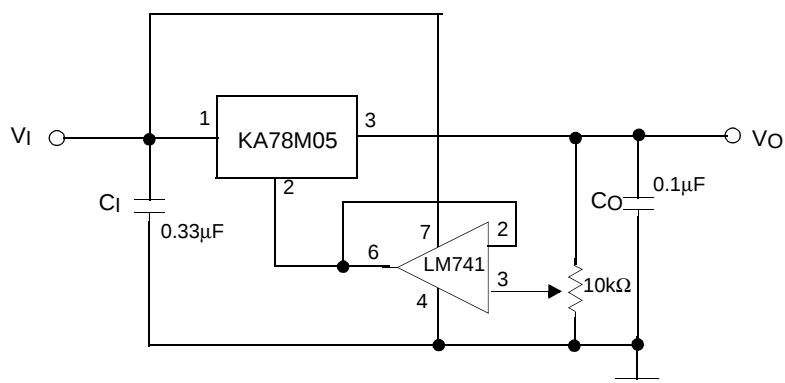


Figure 4. Adjustable Output Regulator (7 to 30V)

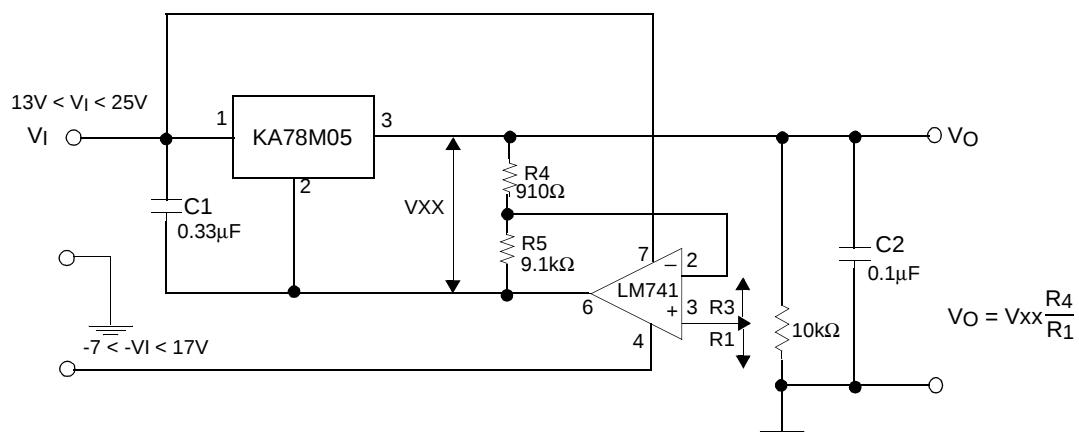
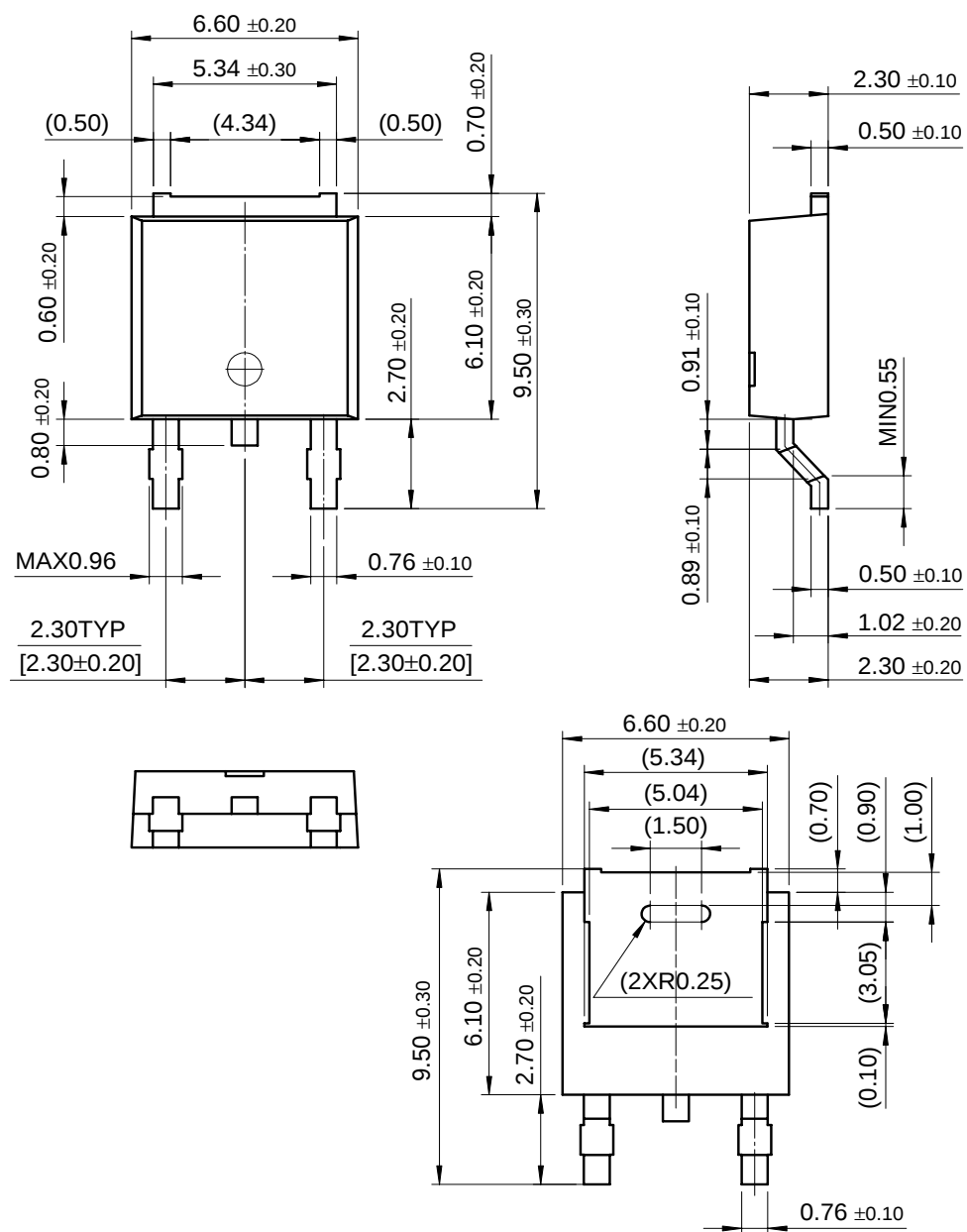


Figure 5. 0.5 to 10V Regulator

Mechanical Dimensions (Continued)**Package**

Dimensions in millimeters

D-PAK

Ordering Information

Product Number	Package	Operating Temperature
KA78M05	TO-220	0 ~ +125°C
KA78M06		
KA78M08		
KA78M12		
KA78M15		
KA78M18		
KA78M24		
KA78M05R	D-PAK	
KA78M06R		
KA78M08R		
KA78M12R		
KA78M08AR		

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